Nuclear Instruments and Methods in Physics Research B68 (1992) 501–508
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NIM B
Beam Interactions
with Materials & Atoms

Author index

Achete, C.A., see Freire Jr., F.L. B68 (1992) 227
Alurralde, M., see Fischer, U.S. B68 (1992) 249
Alves, L.C., see Reis, M.A. B68 (1992) 300
Andersen, H.H., see Sarholt-Kristensen, L. B68 (1992) 258
Andreev, A., see Sarholt-Kristensen, L. B68 (1992) 258
Appel, H., see Sellschop, J.P.F. B68 (1992) 133
Arai, E., H. Funaki, M. Katayama and K. Shimizu, Stoichiometry and profiling of surface layers by means of TOF-E ERDA and RBS B68 (1992) 202
Arends, J., see Zschau, H.-E. B68 (1992) 158
Ascheron, C., J.P. Biersack, D. Fink, P. Goppelt, A. Manuaba, F. Paszti and N.Q. Khanh, Study of proton-bombardment-induced radiation damage in elemental and compound semiconductors by RBS channeling B68 (1992) 443
Aslanoglou, X., see Pilakouta, M. B68 (1992) 141
Assmann, W., see Behrisch, R. B68 (1992) 245

Bachmann, M., see Markwitz, A. B68 (1992) 218
Bange, K., see Wagner, W. B68 (1992) 262
Bante, B., see Müller, D. B68 (1992) 313
Barker, J., J.P. Day, N.D. Priest, D. Newton, P.V. Drumm, J.S. Lilley and G.W.A. Newton, Development of ^{26}Al accelerator mass spectrometry for aluminium absorption experiments in humans B68 (1992) 319
Bassaler, J.M., J.M. Capdevila, O. Gal, F. Lainé, A. Nguyen, J.P. Nicolaï and K. Umiastowski, Rhodotron: an accelerator for industrial irradiation B68 (1992) 92
Baumann, H., see Markwitz, A. B68 (1992) 218
Baumann, H., see Noli, F. B68 (1992) 398
Behrisch, R., see Grambole, D. B68 (1992) 154
Behrisch, R., R. Grötzschel, E. Hentschel and W. Assmann, HIERD analysis of the low-Z deposits on probes from the vessel walls of fusion experiments B68 (1992) 245
Beier, T., see Pantenburg, F.J. B68 (1992) 125
Bench, G., A. Saint, M. Cholewa, G.J.F. Legge, D.L. Weirup and A.E. Pontau, STIM tomography: a three-dimensional high resolution imaging tool B68 (1992) 481
Berg-Sørensen, K., see Hangst, J.S. B68 (1992) 17
Bergmans, R.H., see Brongersma, H.H. B68 (1992) 207
Bermbach, R., see Dönges, G. B68 (1992) 68
Bethge, K., see Mader, A. B68 (1992) 149
Bethge, K., see Markwitz, A. B68 (1992) 218
Bethge, K., see Duggan, J.L. B68 (1992) 495
Bharuth-Ram, K., see Sellschop, J.P.F. B68 (1992) 133
Bibić, N., see Milosavljevic, M. B68 (1992) 426
Biersack, J.P., see Ascheron, C. B68 (1992) 443
Bittner, U., see Müller, D. B68 (1992) 313
Bjurman, B., see Erlandsson, B. B68 (1992) 309
Bohne, W., see Goppelt, P. B68 (1992) 235
Bolse, W. and S.D. Peteves, Modification of the mechanical properties of ceramic surfaces by energetic ion irradiation B68 (1992) 331
Botman, J.I.M., see Hagedoorn, H.L. B68 (1992) 23
Botman, J.I.M., see Webers, G.A. B68 (1992) 83
Botman, J.I.M., see Kleeven, W.J.G.M. B68 (1992) 87
Botman, J.I.M., see Delhez, J.L. B68 (1992) 96
Botman, J.I.M., see Xi, B. B68 (1992) 101
Boubetra, D., see Kerkow, H. B68 (1992) 41
Bowman, C.D., see Jameson, R.A. B68 (1992) 474
Brongersma, H.H., R.H. Bergmans, L.G.C. Buijs, J.-P. Jacobs, A.C. Kruseman, C.A. Severijns and R.G. van Welzenis, Developments in low-energy ion scattering from surfaces B68 (1992) 207

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Buchal, Ch., Ion implantation of optical devices B68 (1992) 355
Buijs, L.G.C., see Brongersma, H.H. B68 (1992) 207
Buoso, M.C., S. Fazinic, A.M.I. Haque, G. Moschini, A. Volpe and G.U. Caravello, Heavy element distribution profiles in archaeological samples of human tooth enamel and dentine using the proton-induced X-ray emission technique B68 (1992) 269

Capdevila, J.M., see Bassaler, J.M. B68 (1992) 92
Caravello, G.U., see Buoso, M.C. B68 (1992) 269
Casteleyn, K., K. Strijckmans and R. Dams, Internal standardization in charged particle activation analysis . . B68 (1992) 161
Cereda, E., see Fazinić, S. B68 (1992) 273
Chen, C.Y., see Lin, E.K. B68 (1992) 281
Cholewa, M., see Bench, G. B68 (1992) 481
Cichocki, T., see Kwiatek, W.M. B68 (1992) 122
Connell, S.H., see Sellschop, J.P.F. B68 (1992) 133
Conner, W.C., see Jones, K.W. B68 (1992) 105
Corts, T., see Milosavljevic, M. B68 (1992) 426

Dams, R., see Casteleyn, K. B68 (1992) 161
Daniel, H., Muons as a probe in solid state and surface physics and in materials research B68 (1992) 459
Day, J.P., see Barker, J. B68 (1992) 319
De Voigt, M.J.A., see Hagedoorn, H.L. B68 (1992) 23
De Voigt, M.J.A., see Dutkiewicz, E. B68 (1992) 305
Deitinghoff, H., see Schempp, A. B68 (1992) 36
Delhez, J.L., see Webers, G.A. B68 (1992) 83
Delhez, J.L., G.A. Webers, J.I.M. Botman, H.L. Hagedoorn, D. Muzio and C.J. Timmermans, Electron beam focusing in a racetrack microtron by means of rotated two-sector dipole magnets B68 (1992) 96
Ditrói, F., S. Takács, I. Mahunka, P. Mikecz and Gy. Tóth, Determination of oxygen in high purity gallium by using charged particle activation analysis B68 (1992) 166
Döbeli, M., see Fischer, U.S. B68 (1992) 249
Dobson, B.R. and G.N. Greaves, XAFS-analysis of materials B68 (1992) 111
Dönges, G., G. Geus, R. Henkel, H. Ries, P. Schall and R. Bermbach, Examination of sea freight containers using modern electron linear accelerators B68 (1992) 68
Drumm, P.V., see Barker, J. B68 (1992) 319
Duggan, J.L. and K. Bethge, Applied research and technology with accelerators. State of the art, 1991 . . . . . B68 (1992) 495
Duschner, H., see Zschau, H.-E. B68 (1992) 158
Dutkiewicz, E., W.J.P. van Kuijen, F. Munnik, P.H.A. Mutsaers, E. Rokita and M.J.A. de Voigt, Determination of Hg concentration in gases by PIXE B68 (1992) 305

Ensinger, W., see Klatt, C. B68 (1992) 277
Ensinger, W., see Frech, G. B68 (1992) 402
Erfurth, W., see Rauschenbach, B. B68 (1992) 438
Erlandsson, B., R. Hellborg, K. Håkansson, G. Skog and B. Bjurman, Measurements of ^{14}C from nuclear power plants with the AMS technique B68 (1992) 309
Esin, S.K., L.V. Kravchuk, V.V. Paramonov, G.V. Romanov and A.A. Stepanov, Possibilities of the DAW structure for application to industrial linacs B68 (1992) 32

Faestermann, T., see Müller, D. B68 (1992) 313
Fazinic, S., see Buoso, M.C. B68 (1992) 269
Fazinić, S., M. Jakšić, L. Kukec, O. Valković, E. Cereda and V. Valkovic, Light element analysis using PIXE and PIGE spectroscopy B68 (1992) 273
Fedina, L.I., see Kachurin, G.A. B68 (1992) 323
Ferrero, M., see Jones, K.W. B68 (1992) 105
Fink, D., see Goppelt, P. B68 (1992) 235
Fink, D., see Ascheron, C. B68 (1992) 443
Finney, J.L., The use of pulsed spallation neutrons in applied condensed matter research B68 (1992) 451
Fischer, U.S., M. Döbeli, M. Suter, M. Alurralde, M. Victoria, R. Gotthardt, R. Schäublin, H. Rühl, W. Wölfli and S. Schwyn, A channeling goniometer with a wide temperature range sample holder B68 (1992) 249
Fisher, J.H., see Hollerman, W.A. B68 (1992) 28
Flagmeyer, R., RBS analysis of heteroepitaxial layered structures B68 (1992) 190
Frech, G., W. Ensinger, H. Müller, M. Hans and G.K. Wolf, A multipurpose implanter with various target chambers for basic studies on the influence of ion bombardment on material properties B68 (1992) 402

Freire Jr., F.L., Ion implantation effects in Na β″-alumina crystals B68 (1992) 422
Freire Jr., F.L., C.M. Lepienski and C.A. Achete, Characterization by Rutherford backscattering, elastic recoil and nuclear reaction analysis of near-surface modifications of glasses submitted to a DC potential B68 (1992) 227
Funaki, H., see Arai, E. B68 (1992) 202

Gal, O., see Bassaler, J.M. B68 (1992) 92
Galka, M., see Kwiatek, W.M. B68 (1992) 122
Gawlik, G., see Kopcewicz, M. B68 (1992) 417
Gaworzewski, P., see Skorupa, W. B68 (1992) 408
Gebauer, B., see Goppelt, P. B68 (1992) 235
Geller, R. and K.S. Golovanivsky, Design of a compact ECRIPAC device for 1–400 MeV/amu heavy ion bunches production B68 (1992) 7
Geus, G., see Dönges, G. B68 (1992) 68
Gillitzer, A., see Müller, D. B68 (1992) 313
Golovanivsky, K.S., see Geller, R. B68 (1992) 7
Goppelt, P., see Ascheron, C. B68 (1992) 443
Goppelt, P., B. Gebauer, D. Fink, M. Wilpert, Th. Wilpert and W. Bohne, High energy ERDA with very heavy ions using mass and energy dispersive spectrometry B68 (1992) 235
Gotthardt, R., see Fischer, U.S. B68 (1992) 249
Grambole, D., see Zschau, H.-E. B68 (1992) 158
Grambole, D., F. Herrmann, R. Klabes, W. Hauffe and R. Behrisch, Investigation of the deuterium distribution in a JET limiter using the nuclear microprobe and ion beam slope cutting B68 (1992) 154
Greaves, G.N., see Dobson, B.R. B68 (1992) 111
Grill, W., Application of free-electron lasers B68 (1992) 61
Groeneveld, K.-O., see Schosnig, M. B68 (1992) 394
Grötzschel, R., see Neelmeijer, C. B68 (1992) 231
Grötzschel, R., see Reuther, H. B68 (1992) 241
Grötzschel, R., see Behrisch, R. B68 (1992) 245
Grund, T., see Wesołowski, P. B68 (1992) 468
Gwilliam, R.M., see Reeson, K.J. B68 (1992) 369

Habraken, F.H.P.M., Light element depth profiling using elastic recoil detection B68 (1992) 181
Hagedoorn, H.L., see Webers, G.A. B68 (1992) 83
Hagedoorn, H.L., see Kleeven, W.J.G.M. B68 (1992) 87
Hagedoorn, H.L., see Delhez, J.L. B68 (1992) 96
Hagedoorn, H.L., see Xi, B. B68 (1992) 101
Hagedoorn, H.L., J.I.M. Botman, P.H.A. Mutsaers and M.J.A. de Voigt, Prospects of analytical models for accelerator technology in industry (past, present, future) B68 (1992) 23
Håkansson, K., see Erlandsson, B. B68 (1992) 309
Hamm, R.W., RF ion linacs for applied research and industrial applications B68 (1992) 1
Hangst, J.S., K. Berg-Sørensen, P.S. Jessen, M. Kristensen, K. Mølmer, J.S. Nielsen, O. Poulsen, J.P. Schiffer and P. Shi, Laser cooling of stored ions in ASTRID: a storage ring for ions and electrons B68 (1992) 17
Hans, M., see Frech, G. B68 (1992) 402
Haque, A.M.I., see Buoso, M.C. B68 (1992) 269
Hartmann, E., see Mehnert, R. B68 (1992) 73
Hauffe, W., see Grambole, D. B68 (1992) 154
Havránek, V., V. Hnatowicz, J. Kvítek, I. Obrusník, V. Rybka and V. Švorčik, Characterization of thin Si_1O_n surface layers on Si by proton and alpha particle backscattering B68 (1992) 223
He, F., see Peng, X. B68 (1992) 145
He, F., see Long, X. B68 (1992) 266
Hellborg, R., see Lindén, M. B68 (1992) 170
Hellborg, R., see Erlandsson, B. B68 (1992) 309
Henkel, R., see Dönges, G. B68 (1992) 68
Hennrich, F., see Pantenburg, F.J. B68 (1992) 125
Hentschel, E., see Behrisch, R. B68 (1992) 245
Herrmann, F., see Grambole, D. B68 (1992) 154
Herrmann, F., see Zschau, H.-E. B68 (1992) 158
Hippler, R., see Schneider, H. B68 (1992) 491
Hippler, R. and S. Reinke, Oxygen dependence of light emission from sputtered atoms and ions following ion bombardment of polycrystalline aluminum targets B68 (1992) 413

Hiramoto, K. and M. Nishi, An operating method to reduce damping time of betatron oscillations at beam injection in an electron storage ring B68 (1992) 79
Hnatowicz, V., see Havránek, V. B68 (1992) 223
Hofman, J., see Webers, G.A. B68 (1992) 83
Holland, L.R., see Hollerman, W.A. B68 (1992) 28
Holldack, K., see Kerkow, H. B68 (1992) 41
Holldack, K., see Kerkow, H. B68 (1992) 389
Hollerman, W.A., L.R. Holland, D.B. Nisen, J.H. Fisher and G.A. Shelby, Development of the fluorescent materials test chamber B68 (1992) 28
Holzschuh, E., see Sellschop, J.P.F. B68 (1992) 133
Huang, Y.M., see Lin, E.K. B68 (1992) 281
Hulek, Z., see Zschau, H.-E. B68 (1992) 158

Jacobs, J.-P., see Brongersma, H.H. B68 (1992) 207
Jagielski, J., see Kopcewicz, M. B68 (1992) 417
Jakšić, M., see Fazinić, S. B68 (1992) 273
Jameson, R.A., G.P. Lawrence and C.D. Bowman, Accelerator-driven transmutation technology for incinerating radioactive waste and for advanced application to power production B68 (1992) 474
Jessen, P.S., see Hangst, J.S. B68 (1992) 17
Johansen, A., see Sarholt-Kristensen, L. B68 (1992) 258
Johnson, E., see Sarholt-Kristensen, L. B68 (1992) 258
Jones, K.W., P. Spanne, W.B. Lindquist, W.C. Conner and M. Ferrero, Determination of polymerization particle morphology using synchrotron computed microtomography B68 (1992) 105

Kachurin, G.A., I.E. Tyschenko and L.I. Fedina, High-temperature ion implantation in silicon B68 (1992) 323
Kalbitzer, S., see Klatt, C. B68 (1992) 277
Katayama, M., see Arai, E. B68 (1992) 202
Kerkow, H., D. Boubetra and K. Holldack, A cold cathode ion source with a magnetic hollow cathode B68 (1992) 41
Kerkow, H., K. Holldack and A. Mertens, Radiation-induced diffusion during ion implantation B68 (1992) 389
Khanh, N.Q., see Ascheron, C. B68 (1992) 443
Klabes, R., see Grambole, D. B68 (1992) 154
Klabes, R., see Zschau, H.-E. B68 (1992) 158
Klabes, R., see Neelmeijer, C. B68 (1992) 231
Klatt, C., W. Ensinger, H. Martin, G.K. Wolf, P. Oberschachtsiek, D. Niemann and S. Kalbitzer, Film thickness determination with PIXE B68 (1992) 277
Kleeven, W.J.G.M., M.E.H.J. Theeuwen, M.H.M. Knoben, A.J. Moerdijk, J.I.M. Botman, J.A. van der Heide, C.J. Timmermans and H.L. Hagedoorn, Numerical design and model measurements for a 1.3 GHz microtron accelerating cavity B68 (1992) 87
Klenert, P., see Mehnert, R. B68 (1992) 73
Knoben, M.H.M., see Kleeven, W.J.G.M. B68 (1992) 87
Koch, M., see Wesołowski, P. B68 (1992) 468
Kögler, R., see Skorupa, W. B68 (1992) 408
Kopcewicz, M., J. Jagielski, G. Gawlik and A. Turos, Phase diagram of implanted FeN system B68 (1992) 417
Körner, H.J., see Müller, D. B68 (1992) 313
Korschinek, G., see Müller, D. B68 (1992) 313
Kravchuk, L.V., see Esin, S.K. B68 (1992) 32
Kreissig, U., see Neelmeijer, C. B68 (1992) 231
Krimmel, E., see Markwitz, A. B68 (1992) 218
Kristensen, M., see Hangst, J.S. B68 (1992) 17
Kroneberger, K., see Schosnig, M. B68 (1992) 394
Kruschke, D., see Neelmeijer, C. B68 (1992) 231
Kruseman, A.C., see Brongersma, H.H. B68 (1992) 207
Kucha, H., see Przybyłowicz, W. B68 (1992) 115
Kukec, L., see Fazinić, S. B68 (1992) 273
Kundig, W., see Sellschop, J.P.F. B68 (1992) 133
Kvítek, J., see Havránek, V. B68 (1992) 223
Kwiatek, W.M., T. Cichocki, M. Galka and C. Paluszkiewicz, Microanalysis using synchrotron radiation B68 (1992) 122

Lainé, F., see Bassaler, J.M. B68 (1992) 92
Lankosz, M., see Przybyłowicz, W. B68 (1992) 115
Lawrence, G.P., see Jameson, R.A. B68 (1992) 474

Legge, G.J.F., see Bench, G. B68 (1992) 481
Lenkeit, K. and A. Pirrwitz, Quantitative depth-dependent structural and strain analysis in superlattices by ion channeling B68 (1992) 253
Lepienski, C.M., see Freire Jr., F.L. B68 (1992) 227
Lieb, K.P., see Uhrmacher, M. B68 (1992) 175
Lieb, K.P., see Milosavljevic, M. B68 (1992) 426
Lilley, J.S., see Barker, J. B68 (1992) 319
Lin, E.K., C.W. Wang, P.K. Teng, Y.M. Huang and C.Y. Chen, Elemental analysis with external-beam PIXE . B68 (1992) 281
Lin, X., see Long, X. B68 (1992) 266
Lindén, M. and R. Hellborg, Crystalline order and disorder in epitaxial GaN B68 (1992) 170
Lindquist, W.B., see Jones, K.W. B68 (1992) 105
Linker, G., see Rauschenbach, B. B68 (1992) 438
Liu, M., see Peng, X. B68 (1992) 145
Liu, M., see Long, X. B68 (1992) 266
Long, X., see Peng, X. B68 (1992) 145
Long, X., X. Peng, F. He, M. Liu and X. Lin, The hydrogen concentration of diamondlike amorphous carbon films by elastic recoil detection analysis B68 (1992) 266

Mader, A., J.D. Meyer and K. Bethge, Lattice location of implanted carbon in GaAs B68 (1992) 149
Madiba, C.C.P., see Sellschop, J.P.F. B68 (1992) 133
Mahunka, I., see Ditrói, F. B68 (1992) 166
Maier, K., see Wesołowski, P. B68 (1992) 468
Major, J., see Wesołowski, P. B68 (1992) 468
Manuaba, A., see Ascheron, C. B68 (1992) 443
Markwitz, A., M. Bachmann, H. Baumann, K. Bethge, E. Krimmel and P. Misaelides, Hydrogen profiles of thin PVD silicon nitride films using elastic recoil detection analysis B68 (1992) 218
Martin, H., see Klatt, C. B68 (1992) 277
Mehnert, R., P. Klenert and E. Hartmann, LEA electron accelerators for radiation processing B68 (1992) 73
Mertens, A., see Kerkow, H. B68 (1992) 389
Meyer, J.D., see Mader, A. B68 (1992) 149
Meyer, O., see Rauschenbach, B. B68 (1992) 438
Mikecz, P., see Ditrói, F. B68 (1992) 166
Milosavljevic, M., T. Corts, K.P. Lieb and N. Bibić, Xenon ion beam mixing in Ni_3N/Al bilayers B68 (1992) 426
Misaelides, P., see Markwitz, A. B68 (1992) 218
Misaelides, P., see Noli, F. B68 (1992) 398
Moerdijk, A.J., see Kleeven, W.J.G.M. B68 (1992) 87
Mohammedein, A.M.M., see Sieber, K. B68 (1992) 292
Mølmer, K., see Hangst, J.S. B68 (1992) 17
Mommsen, H., see Pantenburg, F.J. B68 (1992) 125
Morgenstern, G., see Skorupa, W. B68 (1992) 408
Moschini, G., see Buoso, M.C. B68 (1992) 269
Müller, D., B. Bante, T. Faestermann, A. Gillitzer, H.J. Körner, G. Korschinek and U. Bittner, Accelerator mass spectrometry with a gas-filled magnetic spectrograph B68 (1992) 313
Müller, H., see Frech, G. B68 (1992) 402
Müller, W., see Neelmeijer, C. B68 (1992) 231
Munnik, F., see Dutkiewicz, E. B68 (1992) 305
Musiol, G., see Sieber, K. B68 (1992) 292
Mutsaers, P.H.A., see Hagedoorn, H.L. B68 (1992) 23
Mutsaers, P.H.A., see Dutkiewicz, E. B68 (1992) 305
Muzio, D., see Delhez, J.L. B68 (1992) 96

Neelmeijer, C., R. Grötzschel, R. Klabes, U. Kreissig, W. Müller and D. Kruschke, Simultaneous analysis of Li and B in amorphous thin film glasses using ERDA B68 (1992) 231
Newton, D., see Barker, J. B68 (1992) 319
Newton, G.W.A., see Barker, J. B68 (1992) 319
Nguyen, A., see Bassaler, J.M. B68 (1992) 92
Nicolaï, J.P., see Bassaler, J.M. B68 (1992) 92
Nielsen, J.S., see Hangst, J.S. B68 (1992) 17
Niemann, D., see Klatt, C. B68 (1992) 277
Nisen, D.B., see Hollerman, W.A. B68 (1992) 28
Nishi, M., see Hiramoto, K. B68 (1992) 79

Noli, F., P. Misaelides, P. Spathis, M. Pilakouta and H. Baumann, Oxidation and corrosion studies of Al-implanted stainless steel AISI 321 using nuclear reaction and electrochemical techniques B68 (1992) 398

Oberschachtsiek, P., see Klatt, C. B68 (1992) 277
Obrusník, I., see Havránek, V. B68 (1992) 223
Ottermann, C., see Wagner, W. B68 (1992) 262
Otto, G., see Zschau, H.-E. B68 (1992) 158
Otto, G., see Vogt, J. B68 (1992) 285

Paluszkiewicz, C., see Kwiatek, W.M. B68 (1992) 122
Panknin, D., see Reuther, H. B68 (1992) 241
Pantenburg, F.J., T. Beier, F. Hennrich and H. Mommsen, The fundamental parameter method applied to X-ray fluorescence analysis with synchrotron radiation B68 (1992) 125
Paradellis, T., see Pilakouta, M. B68 (1992) 141
Paramonov, V.V., see Esin, S.K. B68 (1992) 32
Paszti, F., see Ascheron, C. B68 (1992) 443
Patterson, B., see Sellschop, J.P.F. B68 (1992) 133
Peng, X., see Long, X. B68 (1992) 266
Peng, X., X. Long, F. He and M. Liu, Excitation functions for ^{107}Ag(d, 2n)^{107}Cd, ^{109}Ag(d, 2n)^{109}Cd and ^{109}Ag(d, p)^{110m}Ag reactions B68 (1992) 145
Peteves, S.D., see Bolse, W. B68 (1992) 331
Pilakouta, M., see Noli, F. B68 (1992) 398
Pilakouta, M., X. Aslanoglou, A. Savidou, T. Paradellis and E. Sideris, A study of the effects of ^{15}N ion beam irradiation on organic compounds B68 (1992) 141
Pirrwitz, A., see Lenkeit, K. B68 (1992) 253
Plier, F., see Zschau, H.-E. B68 (1992) 158
Pontau, A.E., see Bench, G. B68 (1992) 481
Poulsen, O., see Hangst, J.S. B68 (1992) 17
Priest, N.D., see Barker, J. B68 (1992) 319
Przybyłowicz, W., F. van Langevelde, H. Kucha, M. Lankosz and P. Wyszomirski, Trace element determinations in selected geological samples using a 15 keV synchrotron microprobe at the SRS, Daresbury, UK .. B68 (1992) 115

Querner, G., see Reuther, H. B68 (1992) 241

Rajchel, B., Radiation damage in a CdF_2 ionic crystal by a channeled proton beam B68 (1992) 435
Rauch, F., see Wagner, W. B68 (1992) 262
Rauschenbach, B., W. Erfurth, G. Linker and O. Meyer, Ion beam mixing of Cu/Ti bilayers B68 (1992) 438
Reeson, K.J., R.S. Spraggs, R.M. Gwilliam and B.J. Sealy, Ion beam synthesis of epitaxial $CoSi_2$ layers and the redistribution of dopants within them B68 (1992) 369
Reiche, I., see Sieber, K. B68 (1992) 292
Reinke, S., see Hippler, R. B68 (1992) 413
Reis, M.A. and L.C. Alves, DATTPIXE, a computer package for TTPIXE data analysis B68 (1992) 300
Reuther, H., E. Wieser, D. Panknin, R. Grötzschel, W. Skorupa and G. Querner, Investigation of ion beam synthesized iron silicide by RBS, XRD, and Mössbauer spectroscopy (CEMS) B68 (1992) 241
Ries, H., see Dönges, G. B68 (1992) 68
Riggi, F., PDMS and surface analysis with fast heavy ion beams B68 (1992) 213
Rivière, J.P., Surface modification by ion implantation and ion beam mixing B68 (1992) 361
Rokita, E., see Dutkiewicz, E. B68 (1992) 305
Romanov, G.V., see Esin, S.K. B68 (1992) 32
Rothard, H., see Schosnig, M. B68 (1992) 394
Rühl, H., see Fischer, U.S. B68 (1992) 249
Rybka, V., see Havránek, V. B68 (1992) 223

Saint, A., see Bench, G. B68 (1992) 481
Salomonovic, R., see Zschau, H.-E. B68 (1992) 158
Sarholt-Kristensen, L., A. Andreev, A. Johansen, H.H. Andersen and E. Johnson, Sputtering and RBS investigations of ordered and disordered Ni_4Mo B68 (1992) 258
Savidou, A., see Pilakouta, M. B68 (1992) 141
Schall, P., see Dönges, G. B68 (1992) 68
Schäublin, R., see Fischer, U.S. B68 (1992) 249
Schempp, A. and H. Deitinghoff, Properties of RFQ accelerators for ion implantation B68 (1992) 36

Schiffer, J.P., see Hangst, J.S. . . . B68 (1992) 17
Schippel, S., see Witzmann, A. . . . B68 (1992) 430
Schlösser, D., see Schosnig, M. . . . B68 (1992) 394
Schmalz, K., see Skorupa, W. . . . B68 (1992) 408
Schneider, H., I. Tobehn and R. Hippler, L-shell ionization in Au/Ag foils by electron and positron impact . . B68 (1992) 491
Schosnig, M., H. Rothard, K. Kroneberger, D. Schlösser and K.-O. Groeneveld, Electron emission and desorption from frozen gases under fast (MeV) ion bombardment . . . B68 (1992) 394
Schwyn, S., see Fischer, U.S. . . . B68 (1992) 249
Sealy, B.J., see Reeson, K.J. . . . B68 (1992) 369
Seeger, A., see Wesołowski, P. . . . B68 (1992) 468
Sellschop, J.P.F., S.H. Connell, C.C.P. Madiba, E. Sideras-Haddad, M.C. Stemmet, K. Bharuth-Ram, H. Appel, W. Kundig, B. Patterson and E. Holzschuh, Hydrogen in and on natural and synthetic diamond . . B68 (1992) 133
Sené, M.R., Applications of electron accelerators in radioactive waste inspection and assay . . . B68 (1992) 53
Setvak, M., see Zschau, H.-E. . . . B68 (1992) 158
Severijns, C.A., see Brongersma, H.H. . . . B68 (1992) 207
Shelby, G.A., see Hollerman, W.A. . . . B68 (1992) 28
Shi, P., see Hangst, J.S. . . . B68 (1992) 17
Shimizu, K., see Arai, E. . . . B68 (1992) 202
Sideras-Haddad, E., see Sellschop, J.P.F. . . . B68 (1992) 133
Sideris, E., see Pilakouta, M. . . . B68 (1992) 141
Sieber, K., A.M.M. Mohammedein, G. Musiol, I. Reiche and G. Zschornack, X-ray intensity ratios for microprobes and PIXE . . . B68 (1992) 292
Skog, G., see Erlandsson, B. . . . B68 (1992) 309
Skorupa, W., see Reuther, H. . . . B68 (1992) 241
Skorupa, W., R. Kögler, M. Voelskow, K. Schmalz, G. Morgenstern and P. Gaworzewski, MeV carbon implantation into silicon: microstructure and electrical properties . . . B68 (1992) 408
Spanne, P., see Jones, K.W. . . . B68 (1992) 105
Spathis, P., see Noli, F. . . . B68 (1992) 398
Spraggs, R.S., see Reeson, K.J. . . . B68 (1992) 369
Stemmet, M.C., see Sellschop, J.P.F. . . . B68 (1992) 133
Stepanov, A.A., see Esin, S.K. . . . B68 (1992) 32
Stoll, H., see Wesołowski, P. . . . B68 (1992) 468
Straede, Chr.A., Ion implantation as an efficient surface treatment . . . B68 (1992) 380
Strijckmans, K., see Casteleyn, K. . . . B68 (1992) 161
Suter, M., see Fischer, U.S. . . . B68 (1992) 249
Švorčik, V., see Havránek, V. . . . B68 (1992) 223

Takács, S., see Ditrói, F. . . . B68 (1992) 166
Teng, P.K., see Lin, E.K. . . . B68 (1992) 281
Theeuwen, M.E.H.J., see Kleeven, W.J.G.M. . . . B68 (1992) 87
Timmermans, C.J., see Webers, G.A. . . . B68 (1992) 83
Timmermans, C.J., see Kleeven, W.J.G.M. . . . B68 (1992) 87
Timmermans, C.J., see Delhez, J.L. . . . B68 (1992) 96
Timmermans, C.J., see Xi, B. . . . B68 (1992) 101
Tobehn, I., see Schneider, H. . . . B68 (1992) 491
Török, I., High resolution PIXE using different orders of reflection . . . B68 (1992) 289
Tóth, Gy., see Ditrói, F. . . . B68 (1992) 166
Turos, A., see Kopcewicz, M. . . . B68 (1992) 417
Tyschenko, I.E., see Kachurin, G.A. . . . B68 (1992) 323

Uhrmacher, M. and K.P. Lieb, Sodium diffusion in metals observed by the $^{26}Na(p, \gamma)$ reaction . . . B68 (1992) 175
Umiastowski, K., see Bassaler, J.M. . . . B68 (1992) 92

Valković, O., see Fazinić, S. . . . B68 (1992) 273
Valkovic, V., see Fazinić, S. . . . B68 (1992) 273
Van der Heide, J.A., see Kleeven, W.J.G.M. . . . B68 (1992) 87
Van Kuijen, W.J.P., see Dutkiewicz, E. . . . B68 (1992) 305
Van Langevelde, F., see Przybyłowicz, W. . . . B68 (1992) 115
Van Welzenis, R.G., see Brongersma, H.H. . . . B68 (1992) 207
Victoria, M., see Fischer, U.S. . . . B68 (1992) 249
Voelskow, M., see Skorupa, W. . . . B68 (1992) 408

Vogt, J., see Zschau, H.-E. B68 (1992) 158
Vogt, J., C. Wirth, H.-E. Zschau and G. Otto, Elemental analysis of mineral grains by means of simultaneous use of PIXE, PIGE and proton backscattering B68 (1992) 285
Volpe, A., see Buoso, M.C. B68 (1992) 269

Wagner, W., F. Rauch, C. Ottermann and K. Bange, Analysis of tungsten oxide films using MeV ion beams . . B68 (1992) 262
Wang, C.W., see Lin, E.K. B68 (1992) 281
Webers, G.A., see Delhez, J.L. B68 (1992) 96
Webers, G.A., J.L. Delhez, J.I.M. Botman, H.L. Hagedoorn, J. Hofman and C.J. Timmermans, Fringe field calculations for the inhomogeneous Twente Eindhoven microtron magnets B68 (1992) 83
Weihreter, E., Superconducting synchrotron radiation sources for industrial applications B68 (1992) 45
Weirup, D.L., see Bench, G. B68 (1992) 481
Wesch, W., Ion implantation in III–V compounds B68 (1992) 342
Wesołowski, P., K. Maier, J. Major, A. Seeger, H. Stoll, T. Grund and M. Koch, A continuous time-tagged positron beam and its application to materials research B68 (1992) 468
Wieser, E., see Reuther, H. B68 (1992) 241
Wilpert, M., see Goppelt, P. B68 (1992) 235
Wilpert, Th., see Goppelt, P. B68 (1992) 235
Wirth, C., see Vogt, J. B68 (1992) 285
Witzmann, A., S. Schippel and A. Zentgraf, Influence of implantation defects on the nucleation and growth of $CoSi_2$ precipitates B68 (1992) 430
Wolf, G.K., see Klatt, C. B68 (1992) 277
Wolf, G.K., see Frech, G. B68 (1992) 402
Wölfli, W., see Fischer, U.S. B68 (1992) 249
Wyszomirski, P., see Przybyłowicz, W. B68 (1992) 115

Xi, B., J.I.M. Botman, C.J. Timmermans and H.L. Hagedoorn, Design study of the storage ring EUTERPE . . B68 (1992) 101

Zentgraf, A., see Witzmann, A. B68 (1992) 430
Zschau, H.-E., see Vogt, J. B68 (1992) 285
Zschau, H.-E., F. Plier, J. Vogt, G. Otto, H. Duschner, J. Arends, D. Grambole, F. Herrmann, R. Klabes, R. Salomonovic, Z. Hulek and M. Setvak, Test of a new standard for fluorine determination with PIGE B68 (1992) 158
Zschornack, G., see Sieber, K. B68 (1992) 292